




# EMC TEST REPORT

<b>Project No.</b>	LBE20136104	<b>Issue No.</b>	0
<b>Applicant</b>	<b>Name of organization</b>	Samsung Electronics Co., Ltd.	
	<b>Address</b>	(Maetan dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 443-742, Republic of Korea	
	<b>Date of application</b>	December 13, 2013	
<b>EUT</b>	<b>Type of device</b>	<input checked="" type="checkbox"/> Class B personal computers and peripherals <input type="checkbox"/> All other devices	
	<b>Equipment authorization</b>	<input type="checkbox"/> Declaration of Conformity <input checked="" type="checkbox"/> Certification <input type="checkbox"/> Verification	
	<b>FCC ID</b>	A3LSMN7505	
	<b>Kind of product</b>	Mobile Phone	
	<b>Model No.</b>	SM-N7505	
	<b>Variant Model No.</b>	Refer to clause 4.6	
	<b>Manufacturer</b>	SAMSUNG ELECTRONICS CO., LTD. 94-1, Imsu-dong, Gumi-si, Gyengsangbuk-do, 730-722, Republic of Korea  SAMSUNG ELECTRONICS HUIZHOU CO.,LTD. 516229, Chenjiang Town, HuiZhou City, Guangdong Province, China	
<b>Applied Standards</b>	FCC Part 15, Subpart B, Class B / ANSI C63.4-2009		
<b>Test Period</b>	December 23, 2013 ~ December 30, 2013		
<b>Issue date</b>	January 2, 2014		
<b>Test result : Complied</b>			
<p>The equipment under test has found to be compliant with the applied standards.          (Refer to the attached test result for more detail.)</p>			
<b>Tested by</b> : Hee-Sung Kim		<b>Reviewed by</b> : Jong-Sup Jeong	
			
<p>The test results in this report only apply to the tested sample. This report must not be reproduced, except in full, without written permission from CS &amp; Environment center.</p>			
			
<p>(Maetan dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-so, 443-742, Republic of Korea          Tel: 82 31 279 1750, Fax: 82 31 279 1745</p>			

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## 1. Report Information

### 1.1 Revision history

No.	Revised detailed information
Issue 0	There are no revisions and this version is basic test report.

## 2. Summary of test results

### 2.1 Emission

The EUT has been tested according to the following specifications:

Applied	Test type	Applied standard	Result
<input checked="" type="checkbox"/>	Conducted Disturbance (Mains port)	FCC Part 15 Subpart B / ANSI C63.4-2009 (Class B)	Complied
<input checked="" type="checkbox"/>	Radiated Disturbance		Complied

## 3. General Information

### 3.1 Test facility

The CS & Environment center is located on Samsung Electronics Co., Ltd. at (Maetan dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Republic of Korea.

All testing are performed in Semi-anechoic chambers conforming to the site attenuation characteristics defined by ANSI C63.4, CISPR 22, 16-1 and 16-2. and Shielded rooms.

The CS & Environment center is operated as testing laboratory in accordance with the requirements of ISO/IEC 17025:2005.

## 4. Test Setup configuration

### 4.1 Test Peripherals

The cables used for these peripherals are either permanently attached by the peripheral manufacturer or coupled with an assigned cable as defined below.

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Mark	Description	Model No.	Serial No.	Manufacturer / Trademark	FCC ID / DoC
A	Mobile Phone	SM-N7505	-	SAMSUNG	A3LSMN7505
B	Battery	EB-BN750BBE	YSsDC03AS/2-B	SAMSUNG	-
C	Headset	EHS64AVFWE	-	SAMSUNG	-
D	Data Cable	ECB-DU4AWE	-	SAMSUNG	-
E	Micro SD Card	16GB	-	SANDISK	-
F	Desk-Top Computer	DM300S3A	EBDEDC6FFD	SAMSUNG	DoC
			-	SAMSUNG	DoC
G	LCD TV Monitor	CF19MS	CF19H1LS700048Y	SAMSUNG	DoC
		EF23TS	EM23H1LS300070L	SAMSUNG	DoC
H	Mouse	SML-210PB	TAKD125021R	SAMSUNG	DoC
I	Keyboard	SDM8500P	8M001183	SAMSUNG	DoC
J	Router	J9794A	CN33FQ71XK	HP	DoC
K	Power Supply	EADP-15DC A	DIKD1245096576	HP	DoC

### 4.2 EUT operating mode

To achieve compliance applied standard specification, the following mode(s) were made during compliance testing:

<b>Operating Mode 1</b>	USB Mode (Data Communication)
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### 4.3 Details of Sampling

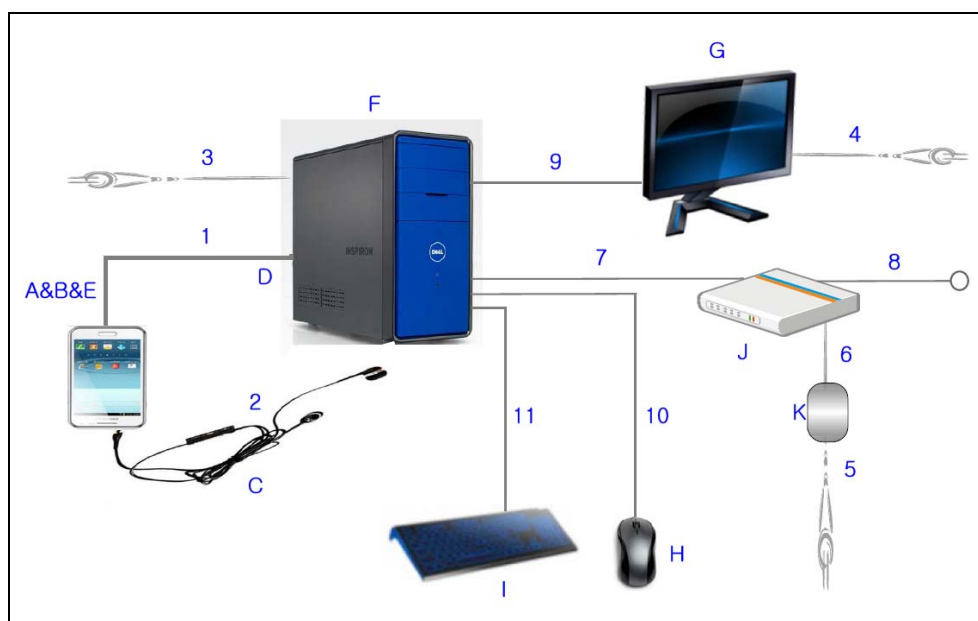
Customer selected, single unit.

## 4.4 Used cable description

The EUT is configured, installed, arranged and operated in a manner consistent with typical applications. Interface cables/loads/devices are connected to at least one of each type of interface port of the EUT, and where practical, each cable shall be terminated in a device typical of actual usage. The type(s) of interconnecting cables to be used and the interface port (of the EUT) to which these were connected:

No.	Connected cable	Length [m]	Shielded [Y/N]	Note
1	USB	1.0	Yes	From EUT to Desk-Top Computer
2	Headset	1.2	No	For EUT
3	Power	1.8	No	For Desk-Top Computer
4	Power	1.8	No	For LCD TV Monitor
5	Power	1.8	No	For Power Supply
6	Power	1.8	No	From Router to Power Supply
7	LAN	1.5	No	From Desk-Top Computer to Router
8	LAN	1.5	No	From Router to Local Area Network
9	RGB	1.8	Yes	From Desk-Top Computer to LCD TV Monitor
10	PS/2	1.8	Yes	From Desk-Top Computer to Mouse
11	PS/2	1.8	Yes	From Desk-Top Computer to Keyboard

## 4.5 Test arrangement



## 4.6 EUT Description

4.6.1 The following features describe EUT represented by this report:

Item	Specification	
Operating Temperature (°C)	-20 ~ +60	
Operating Humidity (%)	0 ~ 95	
Frequency Range	GSM 850	TX : 824.2 ~ 848.8 MHz RX : 869.2 ~ 893.8 MHz
	GSM 1900	TX : 1 850.2 ~ 1 909.8 MHz RX : 1 930.2 ~ 1 989.8 MHz
	WCDMA B2	TX : 1 852.4 ~ 1 907.6 MHz RX : 1 932.4 ~ 1 987.6 MHz
	WCDMA B5	TX : 826.4 ~ 846.6 MHz RX : 871.4 ~ 891.6 MHz
	LTE B5	TX : 824.2 ~ 848.8 MHz RX : 869.2 ~ 848.8 MHz

4.6.2 The variant models

- None

## 4.7 Clock Frequencies

Kind of Clocks	Frequency [ MHz ]
CPU	1 700

## 4.8 Test configuration and condition

- The EUT exercise program which is the samsung standardized emission test program for Windows was used during all EMC measurements were tested. This program was contained on the PC hard disk drive. Once loaded, the program sequentially exercises each system component in turn.
- The EUT was exercised during the testing by data read and write cycles repeated with internal storage devices. At the end of the test, the copied back data was compared with original.
- The EUT was connected to the PC by using USB data cable to charge.
- The system was configured for testing in a typical fashion that a customer would normally use, and was tested while in an automated non-attendant mode.

Power source for the EUT operating was supplied by CVCF made by the Pacific Power Source Corp.

**- Test Voltage : AC 120 V, 60 Hz**

## 4.9 Measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus: (According to CISPR 16-4 and UKAS Lab 34.)

### 4.9.1 Emission

Test type		Measurement uncertainty (C.L. 95 %, k = 2)
Conducted disturbance	AC Mains	3.12 dB
Radiated Disturbance (30 MHz ~ 1 GHz)	Horizontal	4.03 dB
	Vertical	4.13 dB
Radiated Disturbance (1 GHz ~ 6 GHz)	Horizontal	4.53 dB
	Vertical	4.51 dB

## 5. Results of individual test

### 5.1 Conducted disturbance

The EUT was connected to the Desk-Top Computer which was powered from one LISN for the measurements. The support equipment power cables were connected to a second LISN.

Both conducted lines are measured in Quasi-Peak and Average mode, including the worst-case data points for each tested configuration. The EUT measured in accordance with the methods described in standards.

#### Limits for conducted disturbance at the mains ports of Class B ITE

Frequency range Limits [ MHz ]	Resolution Bandwidth [ kHz ]	Limits [ dB(μV) ]	
		Quasi-peak	Average
0,15 to 0,50	9	66 to 56	56 to 46
0,50 to 5	9	56	46
5 to 30	9	60	50

NOTE 1 The lower limit shall apply at the transition frequency.  
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

#### 5.1.1 Test instrumentation

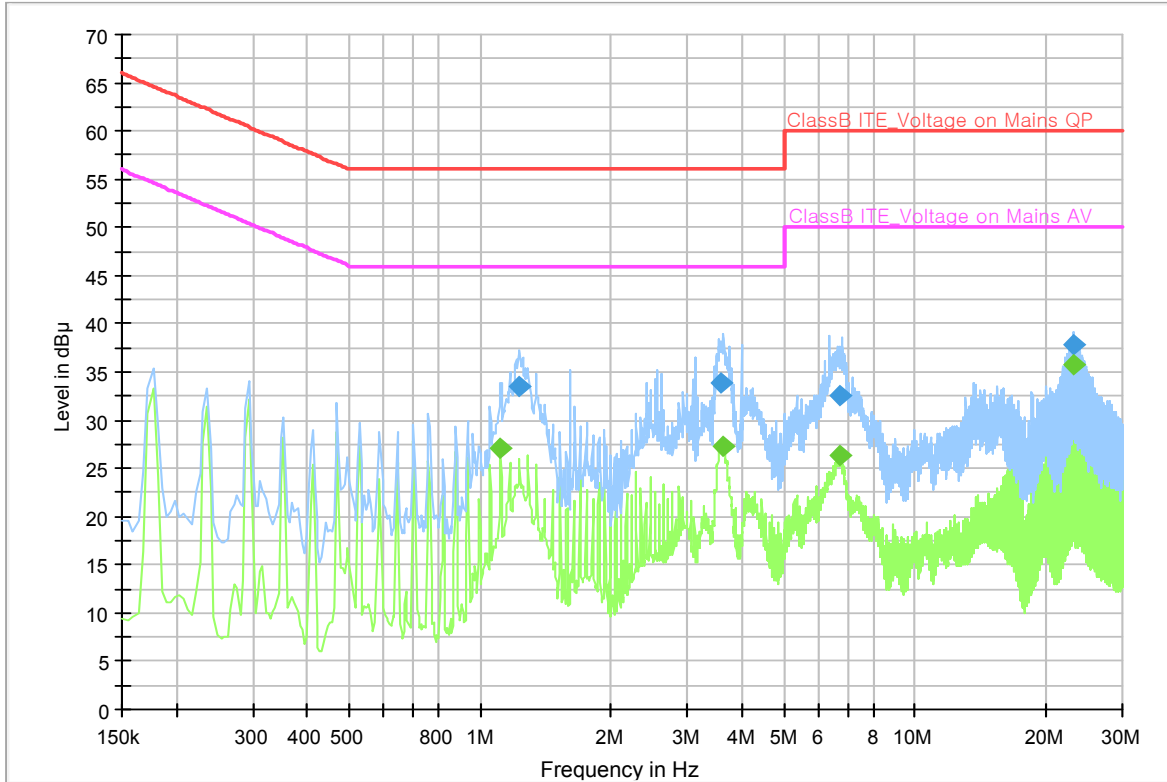
EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-010	LISN	ESH3-Z5	R&S	100263	2013-10-17	12
E5I-016	EMI Test Receiver	ESU8	R&S	100482	2013-06-11	12
E5I-043	LISN	ENV216	R&S	101630	2013-06-07	12

#### 5.1.2 Temperature and humidity condition

Test date	2013-12-30	Test engineer	Hee-Sung Kim
Climate condition	Ambient temperature	22.5 °C	Limit (15.0 to 35.0) °C
	relative humidity	38.6 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	102.0 kPa	Limit (86.0 to 106.0) kPa
Test place	Shield Room (SR14)		

### 5.1.3 Test results

#### Operating Mode 1: AC Mains



Note 1) Two graphs measured for both Live(L1) and Neutral(N) of the LISN are combined into one graph.

Quasi-peak /CAV final measurement results table:

Frequency (MHz)	QuasiPeak (dBµV)	CAV (dBµV)	Limit (dBµV)	Margin (dB)	Line	Corr. (dB)
1.115	---	27.1	46.0	18.9	L1	9.8
1.233	33.5	---	56.0	22.5	L1	9.8
3.564	33.9	---	56.0	22.1	N	9.7
3.610	---	27.2	46.0	18.8	N	9.7
6.694	---	26.4	50.0	23.6	L1	9.8
6.742	32.6	---	60.0	27.4	L1	9.8
23.136	---	35.7	50.0	14.3	L1	9.9
23.250	37.9	---	60.0	22.1	N	9.9

Note 2) Level (QP and/or CAV) = Meter Reading (QP and/or CAV) + Corr. (LISN Insertion Loss + Cable Loss)  
 Margin (QP and/or CAV) = Limit – Level (QP and/or CAV)  
 QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor

## 5.2 Radiated disturbance

The following data lists the significant emission frequencies, measured levels, correction factors (for antenna and cables), orientation of table, polarization and height of antenna, the corrected reading, the limit, and the amount of margin.

Peak measurements were made over the changeable frequency range 30 MHz to 1 GHz at a measurement distance of 10 m for the following antenna and turntable arrangements:

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ kHz ]	Video Bandwidth [ kHz ]	Turntable position [ degrees ]
100 ~ 400	Horizontal, Vertical	120	300	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using quasi-peak detectors.

Peak/CISPR-Average measurements were made over the changeable frequency range 1 GHz to 40 GHz or 5th harmonics of the highest frequency in accordance with internal maximum operating frequency at a measurement distance of 3 m for the following antenna and turntable arrangements:

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ MHz ]	Video Bandwidth [ MHz ]	Turntable position [ degrees ]
100 ~ 200	Horizontal, Vertical	1	3	0 ~ 345 (Step size: 15 degrees)

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using peak and CISPR-average detectors.

### Limits for radiated disturbance of Class B ITE at a measuring distance of 3 m and 10 m

Frequency range Limits [ MHz ]	Field Strength		
	3 m [ $\mu\text{V/m}$ ]	3 m [ dB( $\mu\text{V/m}$ ) ]	10 m [ dB( $\mu\text{V/m}$ ) ]
30 to 88	100	40.0	29.5
88 to 216	150	43.5	33.0
216 to 960	200	46.0	35.5
Above 960	500	54.0	43.5

Results checked manually; and points close to the limit line were re-measured.

## 5.2.1 Test instrumentation

EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-017	EMI Test Receiver	ESU8	R&S	100483	2013-06-11	12
E5I-021	EMI Test Receiver	ESU40	R&S	100376	2013-06-11	12
E5I-035	Horn Antenna	HF907	R&S	100507	2013-04-02	24
E5I-072	BiLog Antenna	CBL6112D	Teseq	36009	2013-06-03	24
E5I-071	BiLog Antenna	CBL6112D	Teseq	35384	2013-05-23	24
E5I-073	Preamplifier	310N	Sonoma	332016	2013-06-10	12
E5I-074	Preamplifier	310N	Sonoma	332017	2013-06-10	12

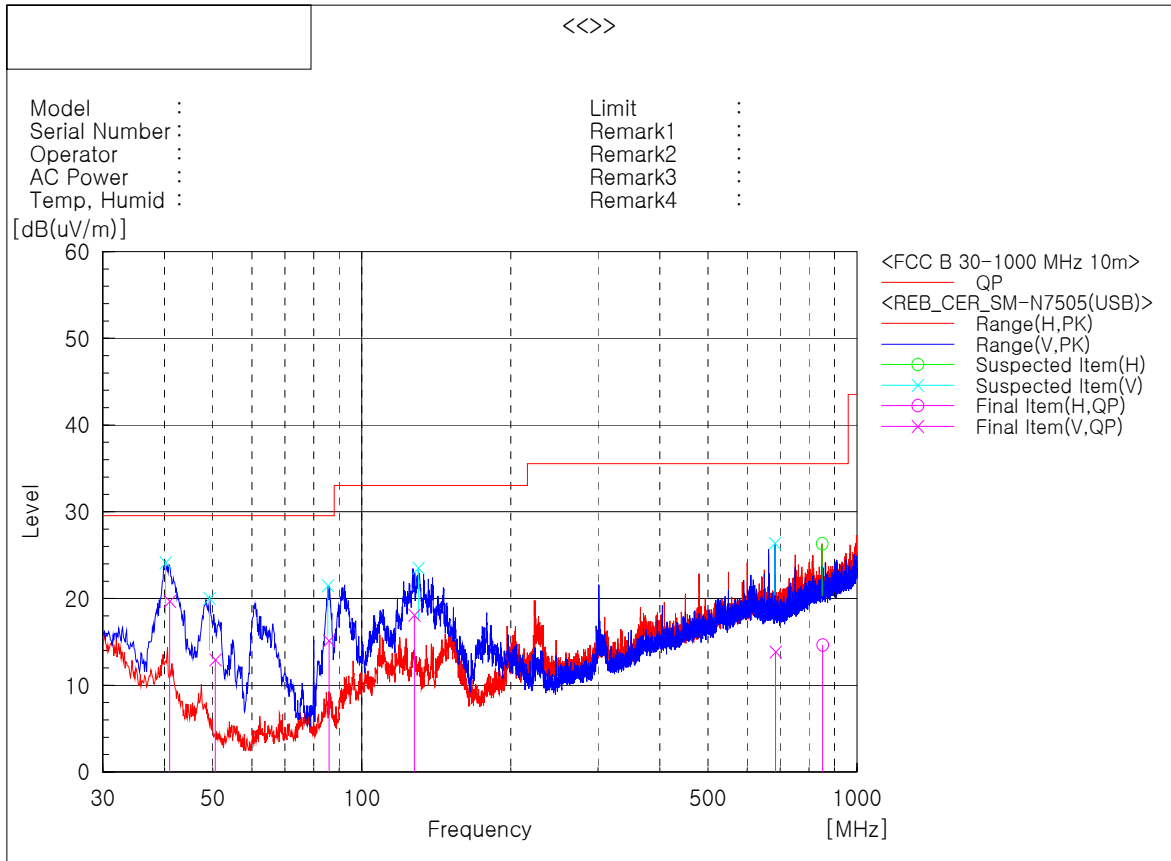
## 5.2.2 Temperature and humidity condition

<b>Test date</b>	2013-12-23	<b>Test engineer</b>	Hee-Sung Kim
<b>Climate condition</b>	Ambient temperature	23.6 °C	Limit (15.0 to 35.0) °C
	Relative humidity	39.7 % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	102.2 kPa	Limit (86.0 to 106.0) kPa
<b>Test place</b>	Semi-Anechoic Chamber (SAC8)		

### 5.2.3 Test results

Operating Mode 1

- Frequencies below 1 GHz



Final Result

No.	Frequency [MHz]	(P)	Reading [dB(uV)]	c.f [dB(1/m)]	Result [dB(uV/m)]	Limit [dB(uV/m)]	Margin [dB]	Height [cm]	Angle [deg]	System	Remark
1	40.951	V	38.6	-18.9	19.7	29.5	9.8	100	264	2	
2	50.611	V	36.3	-23.4	12.9	29.5	16.6	276	256	2	
3	85.928	V	37.9	-22.8	15.1	29.5	14.4	181	358	2	
4	127.816	V	36.6	-18.5	18.1	33.0	14.9	100	32	2	
5	684.934	V	22.8	-9.0	13.8	35.5	21.7	400	163	2	
6	852.840	H	21.6	-7.0	14.6	35.5	20.9	400	130	1	

Note) Receiving antenna polarization : Horizontal, Vertical

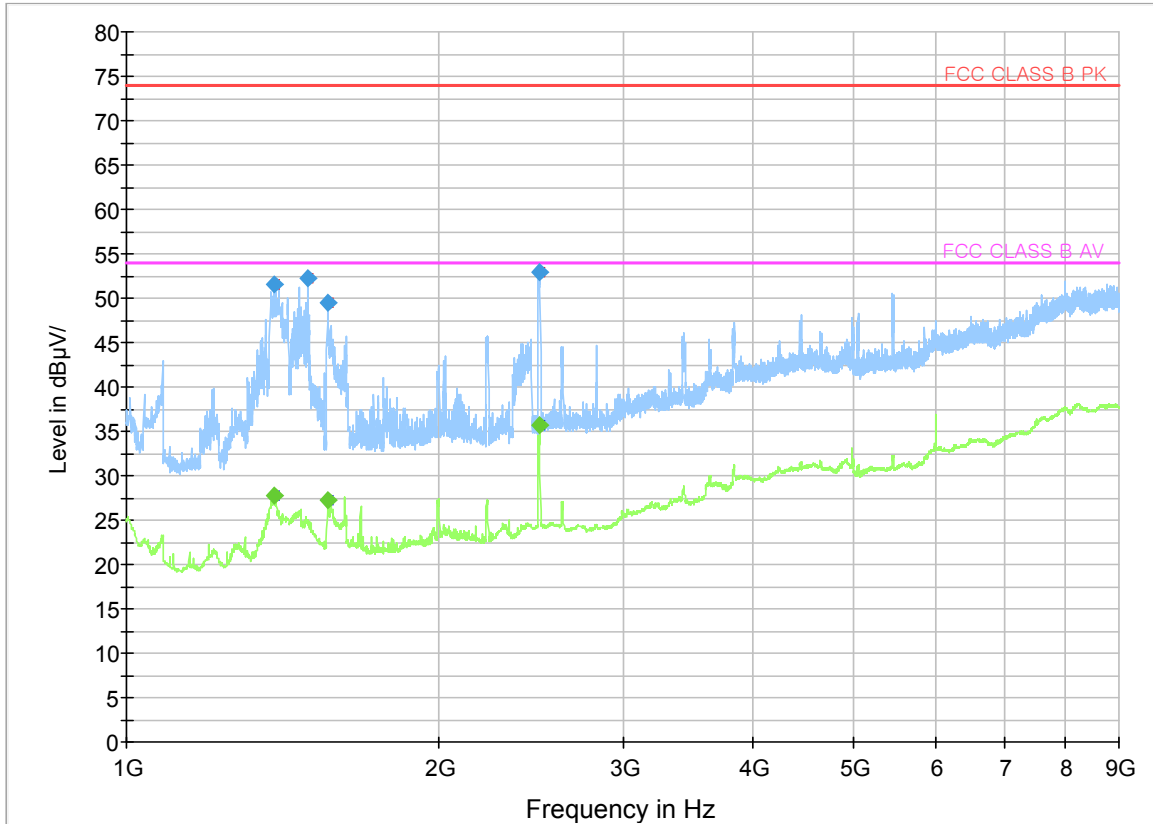
Test Distance : 10 m, Antenna Height : 1 to 4 meters

Level (QP) = Reading (QP) + c.f (Antenna Factor + Cable Loss - Amp. Gain)

Margin (QP) = Limit - Level (QP)

QP = Quasi-Peak, c.f = Correction Factor

**- Frequencies above 1 GHz**



Frequency (MHz)	MaxPeak (dB $\mu$ V/m)	CAV (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1 387.0	---	27.7	54.0	26.3	100.0	V	180.0	-7.5
1 389.0	51.6	---	74.0	22.5	100.0	V	180.0	-7.5
1 495.0	52.2	---	74.0	21.8	100.0	V	45.0	-6.7
1 560.5	49.6	---	74.0	24.4	100.0	V	180.0	-6.2
1 560.5	---	27.3	54.0	26.7	100.0	V	180.0	-6.2
2 496.0	---	35.7	54.0	18.3	100.0	H	270.0	-0.8
2 497.5	52.8	---	74.0	21.2	100.0	H	270.0	-0.8

Note ) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 3 m, Antenna Height : 1 to 2 meters

Level (PK and/or CAV) = Reading (PK and/or CAV) + Corr. (Antenna Factor + Cable Loss - Amp. Gain)

Margin (PK and/or CAV) = Limit – Level (PK and/or CAV)

PK = Peak, CAV = CISPR-Average, Corr. = Correction Factor